

Notice of References Cited	Application/Control No. 10/775,385	Applicant(s)/Patent Under Reexamination BAIZE ET AL.	
	Examiner Sheldon J Richter	Art Unit 3748	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,637,205	10-2003	Ahmad et al.	60/611
	C	US-6,644,029	11-2003	Weinreuter, Bernhard	60/602
	D	US-6,698,203	03-2004	Wang, Yue Yun	60/611
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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